

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10747672	LEE, SANG-DUK
	<b>Examiner</b> Nguyen, Lauren	<b>Art Unit</b> 2871

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
349	58-60, 149-152	03/05/2007	LN

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted Primary Examiner Andrew Schechter	03/06/2007	LN

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>